

## GCMS1P0B120S4B1

### QSiC™ 1200V SiC Half-Bridge Module

#### Features

- 62mm x 152mm industry standard footprint
- High speed switching SiC MOSFETs
- Freewheeling SiC SBD with zero reverse recovery
- All parts tested to above 1350V
- Kelvin reference for stable operation
- ZTA Isolated baseplate

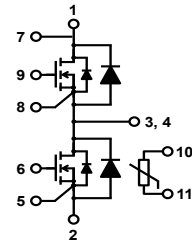
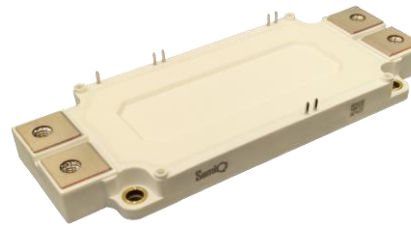
#### Benefits

- Low switching losses
- Low junction to case thermal resistance
- Very rugged and easy mounting
- Direct mounting to heatsink (isolated package)
- Lower  $Q_{RR}$  at high temperature

#### Applications

- Motor drives
- EV applications
- Smart-grid
- Uninterruptible power supply (UPS)

#### Package



Part #	Package	Marking
GCMS1P0B120S4B1	S4	GCMS1P0B120S4B1

**PRELIMINARY**



**Absolute Maximum Ratings, at  $T_J=25^\circ\text{C}$ , unless otherwise specified**

Characteristics	Symbol	Conditions	Values	Unit
Drain-Source Voltage	$V_{\text{rated}}$	$V_{\text{GS}}=0\text{V}$ , $I_{\text{DS}}=1100\mu\text{A}$	1200	V
Continuous Drain Current	$I_{\text{DS}}$	$T_C=25^\circ\text{C}$ , $V_{\text{GS}}=18\text{V}$ , $T_J=175^\circ\text{C}$	1160	A
		$T_C=65^\circ\text{C}$ , $V_{\text{GS}}=18\text{V}$ , $T_J=175^\circ\text{C}$	999	
Body Diode Drain Current	$I_{\text{SD}}$	$T_C=25^\circ\text{C}$ , $V_{\text{GS}}=-4.5\text{V}$ , $T_J=175^\circ\text{C}$	655	
Pulsed Drain Current	$I_{\text{DS,pulse}}$	$T_C=25^\circ\text{C}$ , $V_{\text{GS}}=18\text{V}$	2800	
Gate Source Voltage	$V_{\text{GSmax}}$		-8/22	V
	$V_{\text{GSop}}$	Recommended operational	-4.5/18	
Power Dissipation	$P_{\text{tot}}$	$T_C=25^\circ\text{C}$ , $T_J=175^\circ\text{C}$	2344	W
Junction Temperature	$T_J$	Continuous	-40...175	$^\circ\text{C}$
Case & Storage Temperature	$T_C$ , $T_{\text{storage}}$	Continuous	-40...150	$^\circ\text{C}$

**Static Electrical Characteristics, at  $T_J=25^\circ\text{C}$ , unless otherwise specified**

Characteristics	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_{DS}=16.5mA$	1200	-	-	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=1200V, V_{GS}=0V$	-	0.02	1.1	mA
		$V_{DS}=1200V, V_{GS}=0V, T_J=150^\circ\text{C}$	-	0.34	18	
Gate-Source Leakage Current	$I_{GSS+}$	$V_{GS}=22V, V_{DS}=0V$	-	140	2000	nA
	$I_{GSS-}$	$V_{GS}=-8V, V_{DS}=0V$	-	-140	-2000	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_{DS}=280mA$	1.8	3.1	4	V
		$V_{GS}=V_{DS}, I_{DS}=280mA, T_J=150^\circ\text{C}$	-	2.1	-	
Drain-Source On-Resistance	$R_{DS(on)}^*$	$V_{GS}=18V, I_{DS}=700A$	-	1.2	1.7	m $\Omega$
		$V_{GS}=18V, I_{DS}=700A, T_J=150^\circ\text{C}$	-	1.9	-	
Transconductance	$g_{fs}$	$V_{DS}=20V, I_{DS}=700A$	-	57	-	S
		$V_{DS}=20V, I_{DS}=700A, T_J=150^\circ\text{C}$	-	79	-	
Internal Gate Resistance	$R_{G(int)}$	f=1MHz, $V_{AC}=25mV$ , D-S Short, including internal 0.26 ohm series gate resistor**	-	0.5	-	$\Omega$

\* $R_{DS(on)}$  measured at kelvin and sense pins (pin # 7-8 and pin # 8-5), typical 1 m $\Omega$  chip only

\*\*Internal series gate resistor limits maximum switching frequency defined by Figure 35

**AC Electrical Characteristics, at  $T_J=25^\circ\text{C}$ , unless otherwise specified**

Characteristics	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Input Capacitance	$C_{ISS}$	$V_{GS}=0V, V_{DS}=800V, f=100kHz, V_{AC}=25mV$	-	129.5	-	nF
Output Capacitance	$C_{OSS}$		-	4.95	-	
Reverse Transfer Capacitance	$C_{RSS}$		-	0.19	-	
Coss Stored Energy	$E_{OSS}^{***}$		-	2002	-	$\mu J$
Turn-On Switching Energy	$E_{ON}$	$T_J=25^\circ\text{C}$	-	16.8	-	mJ
		$T_J=125^\circ\text{C}$	-	15.5	-	
		$T_J=150^\circ\text{C}$	-	15.4	-	
Turn-Off Switching Energy	$E_{OFF}$	$T_J=25^\circ\text{C}$	-	16.2	-	
		$T_J=125^\circ\text{C}$	-	18.1	-	
		$T_J=150^\circ\text{C}$	-	18.7	-	
Turn-On Delay Time	$t_{D(on)}$	$V_{DD}=600V, I_{DS}=700A, R_{G(ext)}=1\Omega, V_{GS}=-4.5/+18V, L=8.9\mu H$	-	112	-	ns
Rise Time	$t_R$		-	50	-	
Turn-Off Delay Time	$t_{D(off)}$		-	249	-	
Fall Time	$t_F$		-	99	-	
Total Gate Charge	$Q_G$	$V_{DD}=800V, I_{DS}=700A, V_{GS}=-4.5/+18V$	-	3489	-	nC
Gate to Source Charge	$Q_{GS}$		-	1086	-	
Gate to Drain Charge	$Q_{GD}$		-	727	-	

\*\*\* $E_{OSS}$  is calculated from  $C_{OSS}$  curve

**Freewheeling Diode Characteristics, at  $T_J=25^\circ\text{C}$ , unless otherwise specified**

Characteristics	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Diode Forward Voltage	$V_{SD}$	$V_{GS}=-5\text{V}$ , $I_{SD}=550\text{A}$	-	1.6	1.9	V
		$V_{GS}=-5\text{V}$ , $I_{SD}=550\text{A}$ , $T_J=150^\circ\text{C}$	-	2.2	-	
Reverse Recovery Time	$t_{RR}$	$T_J=25^\circ\text{C}$ $I_S=700\text{A}$ , $V_R=600\text{V}$ , $V_{GS}=-4.5\text{V}$ , $di/dt=16.3\text{A/ns}$	-	38	-	ns
Reverse Recovery Charge	$Q_{RR}$		-	10.2	-	$\mu\text{C}$
Peak Reverse Recovery Current	$I_{RRM}$		-	395	-	A
Reverse Recovery Energy	$E_{RR}$	$T_J=25^\circ\text{C}$	-	3.74	-	mJ
		$T_J=125^\circ\text{C}$	-	5.11	-	
		$T_J=150^\circ\text{C}$ $R_{G(\text{ext})}=1\Omega$	-	5.43	-	

**Thermal and Package Characteristics, at  $T_J=25^\circ\text{C}$ , unless otherwise specified**

Characteristics	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal resistance, junction-case	$R_{thJC, MOSFET}$		-	0.058	0.064	$^\circ\text{C/W}$
	$R_{thJC, DIODE}$		-	0.077	0.085	
Thermal resistance, junction-heatsink	$R_{thJH, MOSFET}$	Thermal grease, Thickness=75 $\mu\text{m}$ , $k = 4.0 \text{ W/mK}$	-	0.070	-	$^\circ\text{C/W}$
	$R_{thJH, DIODE}$		-	0.091	-	
Material of module baseplate	-		-	Cu	-	-
Creepage distance	$d_{\text{Creep}}$	terminal to heatsink	-	14.5	-	mm
	$d_{\text{Creep}}$	terminal to terminal	-	13.0	-	mm
Clearance	$d_{\text{Clear}}$	terminal to heatsink	-	12.5	-	mm
	$d_{\text{Clear}}$	terminal to terminal	-	10.0	-	mm
Comparative tracking index	CTI		250	-	400	-
Mounting torque	$M_d$	M5-0.8 screws	3	-	6	N-m
Terminal connection torque	$M_{dt}$	M6-1.0 screws	3	-	6	N-m
Package weight	$W_t$		-	382	-	g
Isolation voltage	$V_{ISOL}$	$I_{ISOL} < 1\text{mA}$ , 50/60 Hz, 1 min	2500	-	-	V

**NTC Characteristics, at  $T_J=25^\circ\text{C}$ , unless otherwise specified**

Characteristics	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Rated resistance	$R_{NTC}$	$T_{NTC} = 25^\circ\text{C}$	-	5.0	-	k $\Omega$
Resistance tolerance	$\Delta R/R$		-5	-	5	%
Beta Value ( $T_2 = 50^\circ\text{C}$ )	$\beta_{25/50}$	$R_2 = R_{25} \cdot \exp [B_{25/50} (1/T_2 - 1/(298,15 \text{ K}))]$	-	3375	-	k
Power dissipation	$P_{MAX}$	$T_{NTC} = 25^\circ\text{C}$	-	-	50	mW

Typical Performance

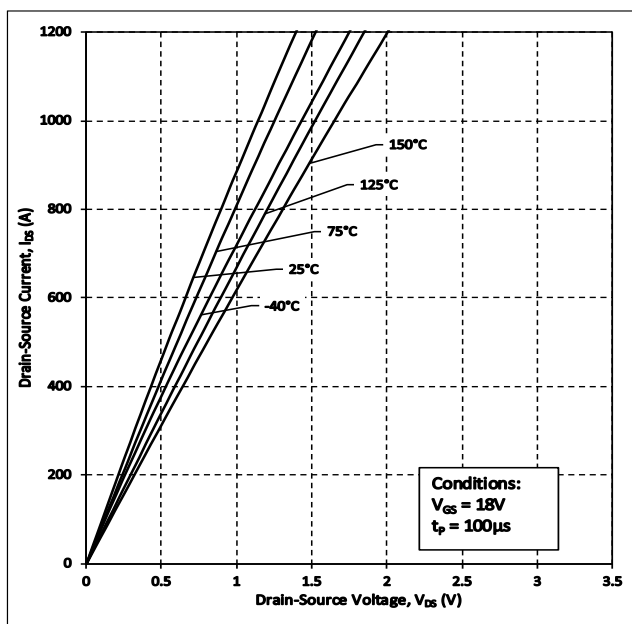


Figure 1. Output Characteristics for Various Temperatures

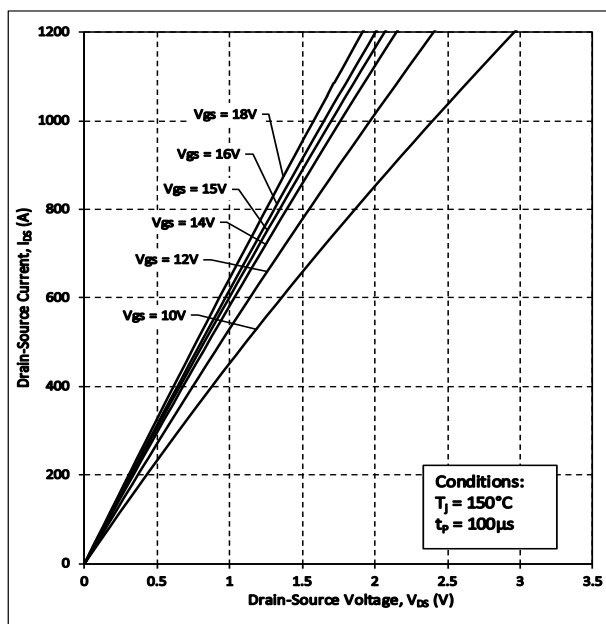


Figure 2. Output Characteristics  $T_J = 150^\circ C$

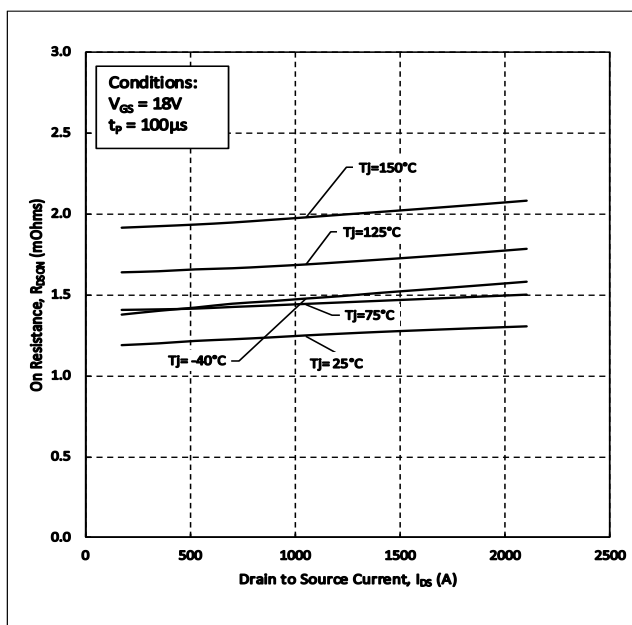


Figure 3. On-Resistance vs. Drain Current For Various Temperatures

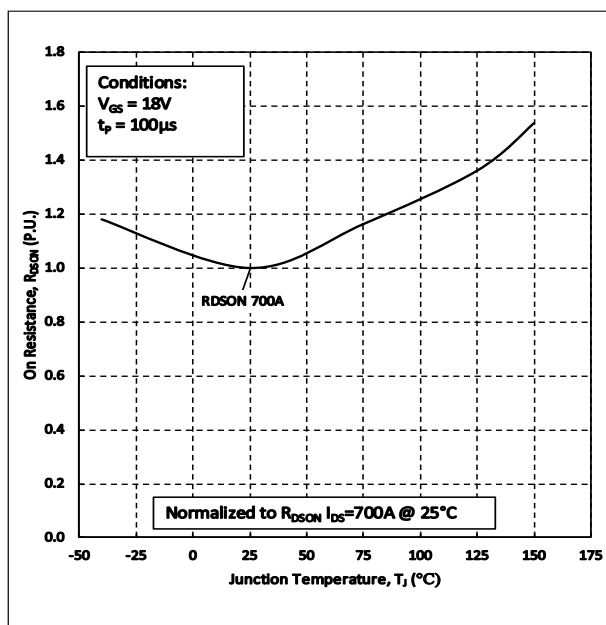


Figure 4. Normalized On-Resistance vs. Temperature

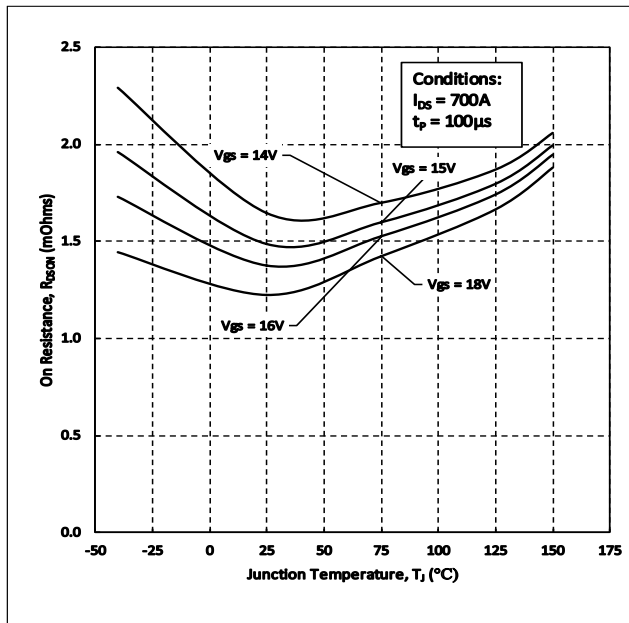


Figure 5. On-Resistance vs. Temperature For Various Gate Voltages

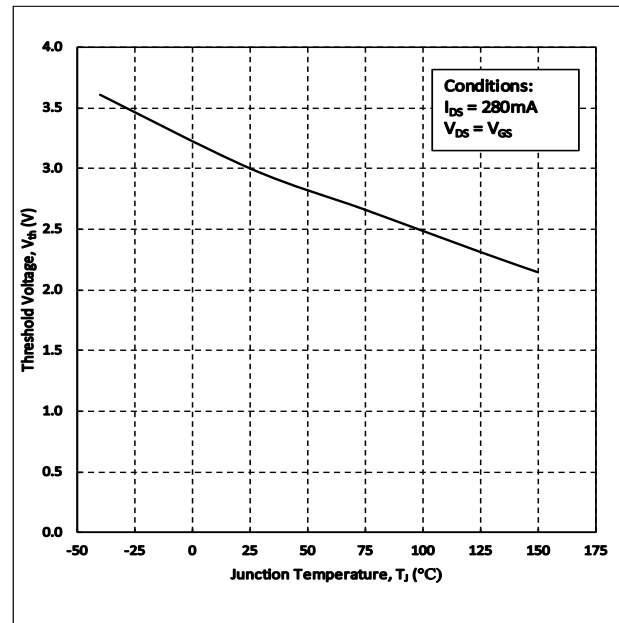


Figure 6. Threshold Voltage vs. Temperature

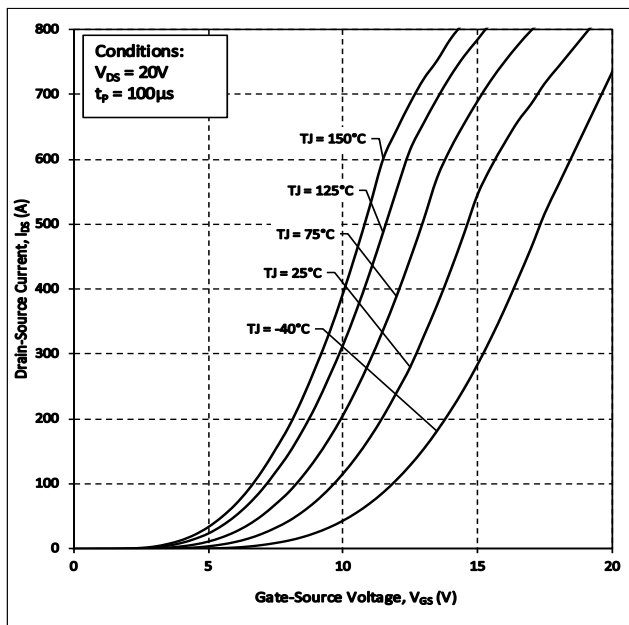


Figure 7. Transfer Characteristic for Various Junction Temperatures

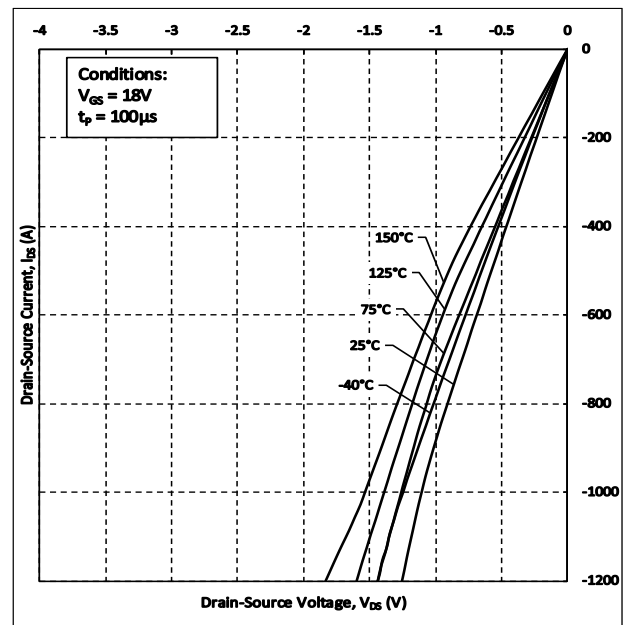


Figure 6. 3rd Quadrant Characteristics at  $V_{GS} = 18V$

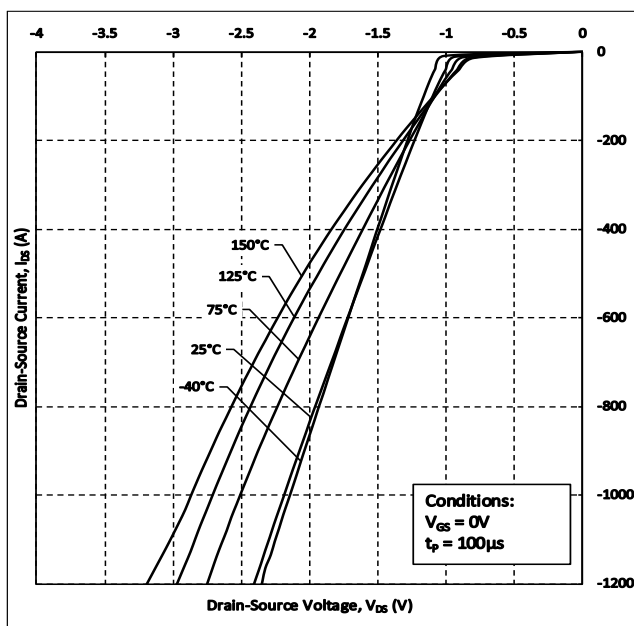


Figure 9. Body Diode Characteristics at  $V_{GS} = 0V$

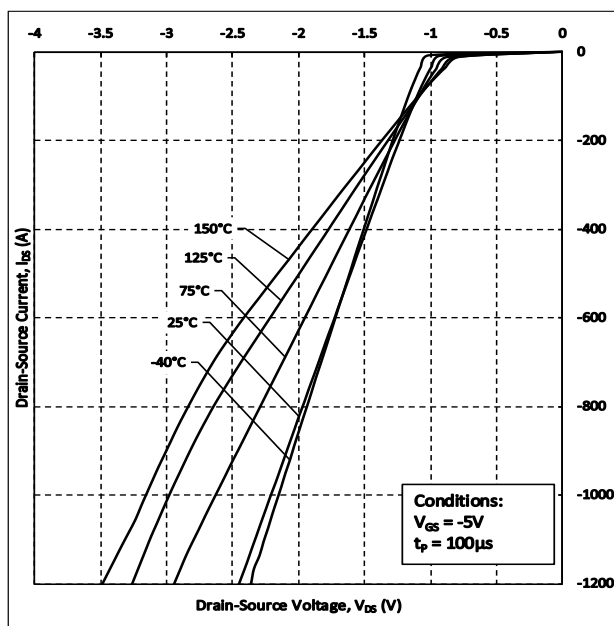


Figure 10. Body Diode Characteristics at  $V_{GS} = -5V$

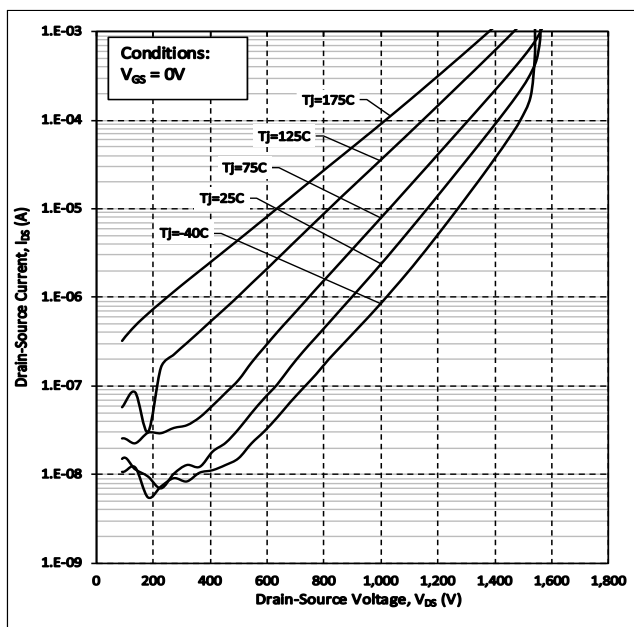


Figure 11.  $I_{DSS}$  vs Temperature

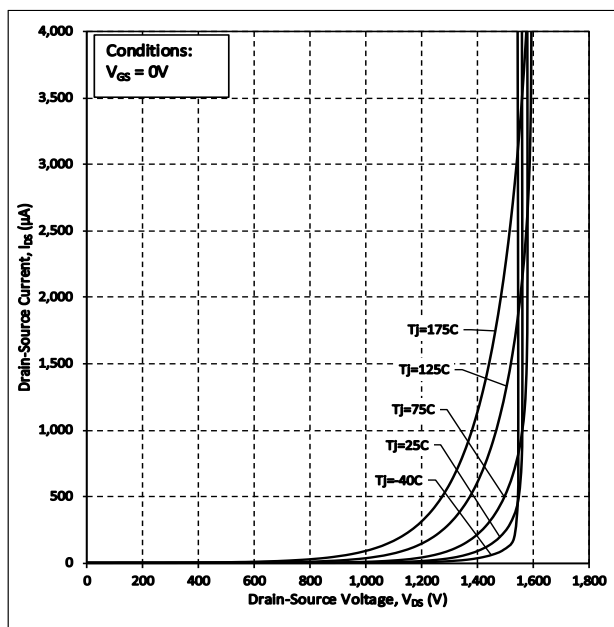


Figure 12.  $BVDSS$  vs Temperature

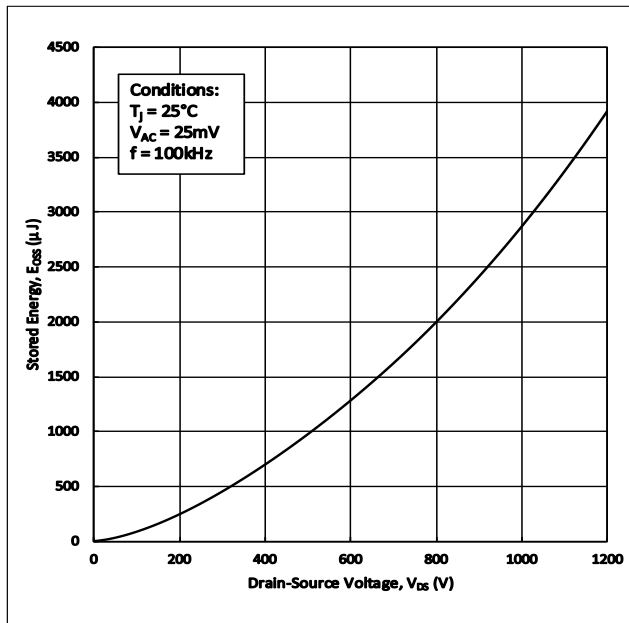


Figure 13. Output Capacitor Stored Energy

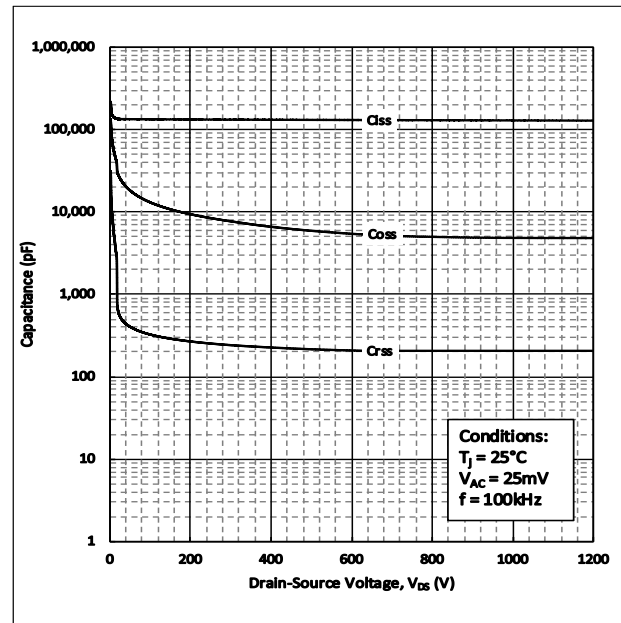


Figure 14. Capacitance vs. Drain-Source Voltage

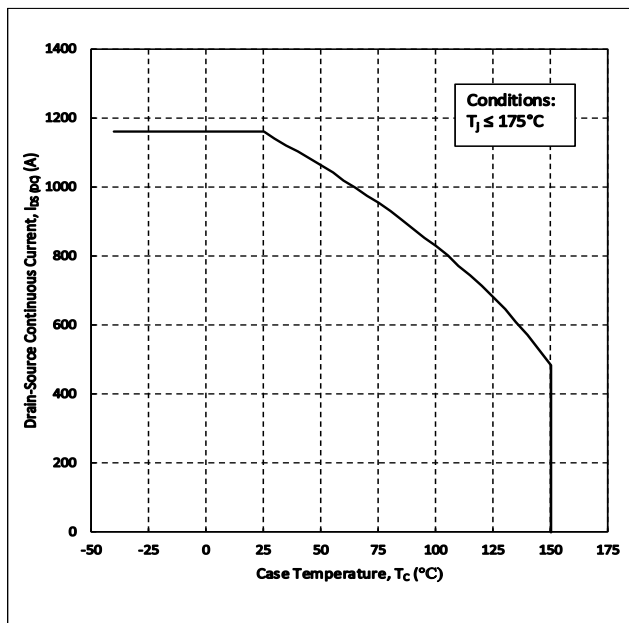


Figure 15. Continuous Drain Current Derating vs. Case Temperature

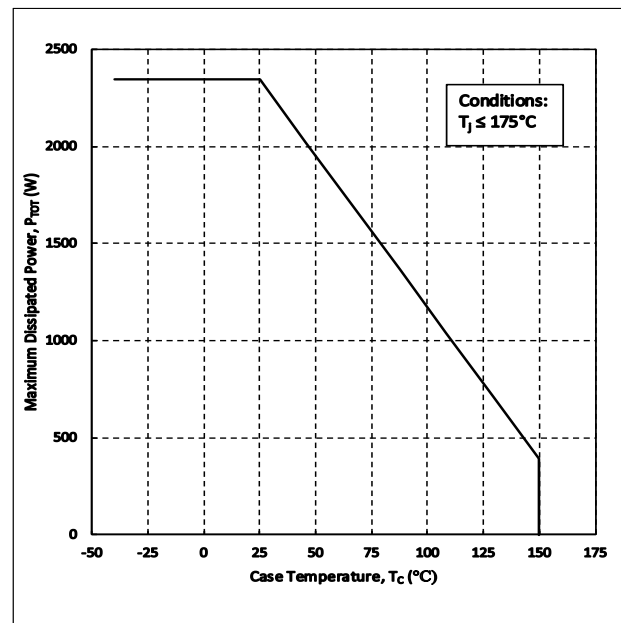


Figure 16. Maximum Power Dissipation Derating vs. Case Temperature

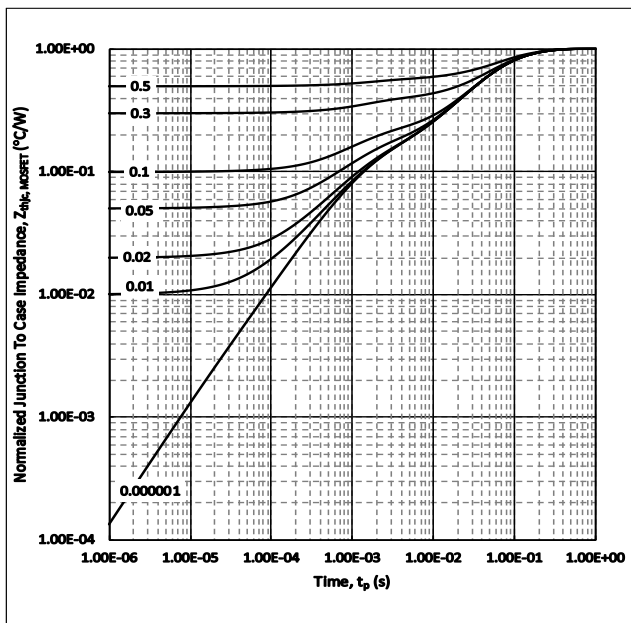


Figure 17. MOSFET Transient Thermal impedance (Junction to Case)

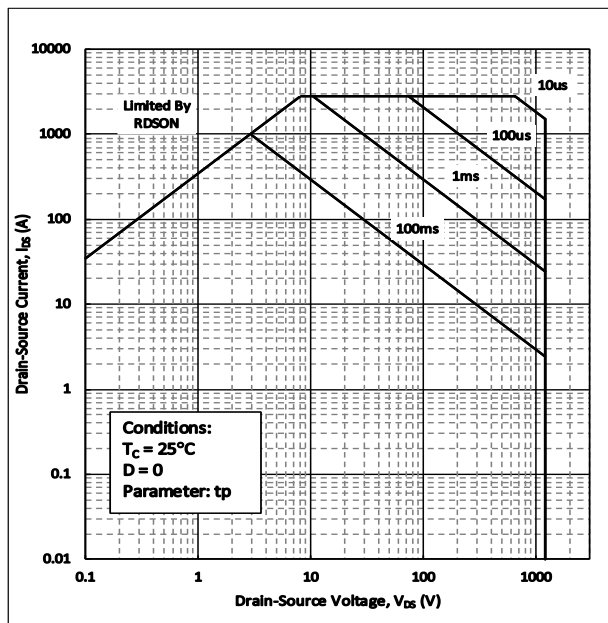


Figure 18. Safe Operating Area

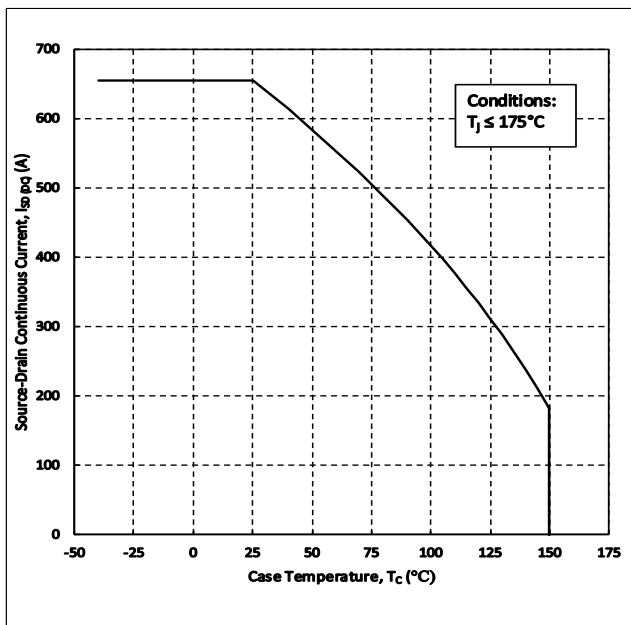


Figure 19. Continuous Source Current Derating vs. Case Temperature

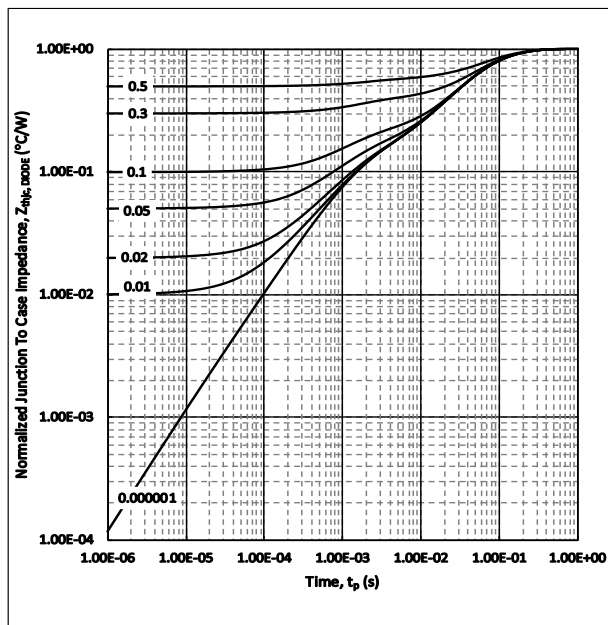


Figure 20. Diode Transient Thermal impedance (Junction to Case)



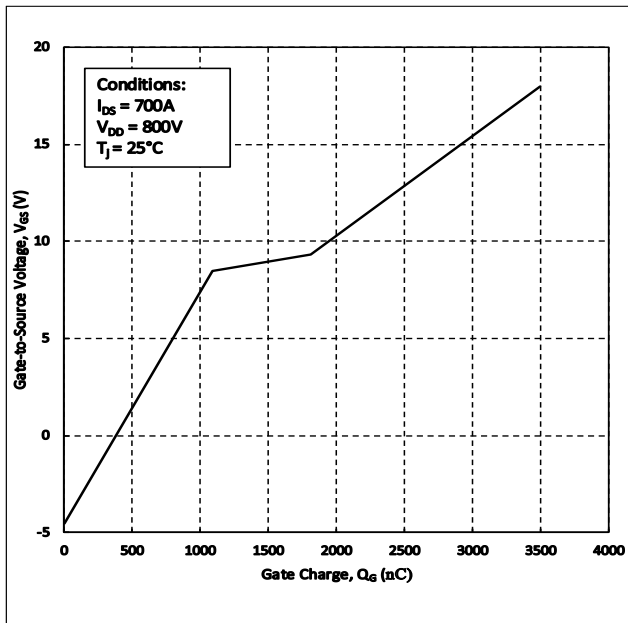


Figure 21. Gate Charge Characteristics

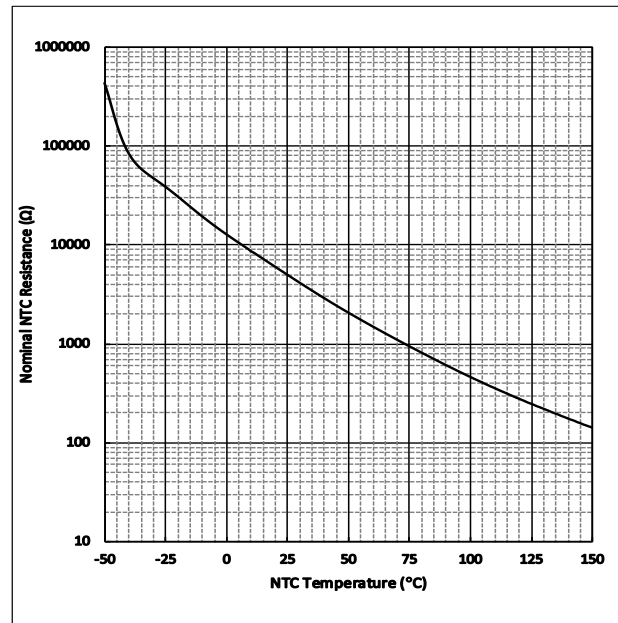


Figure 22. Nominal NTC Resistance vs. Temperature

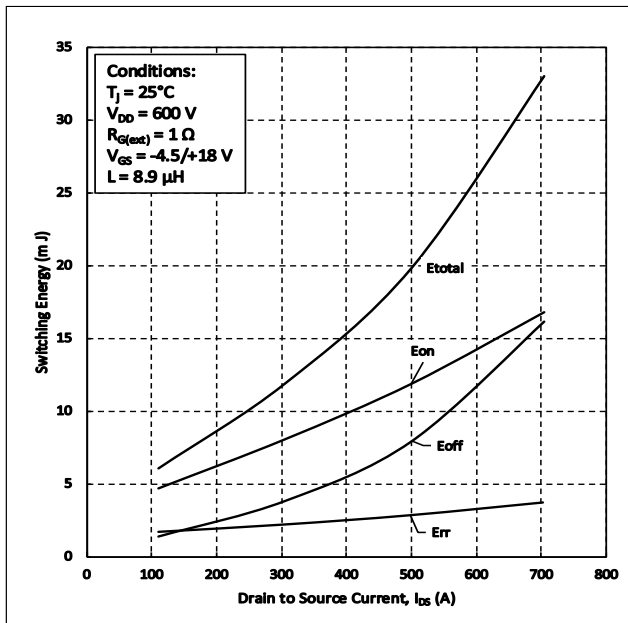


Figure 23. Clamped Inductive Switching Energy vs. Drain Current (600V)

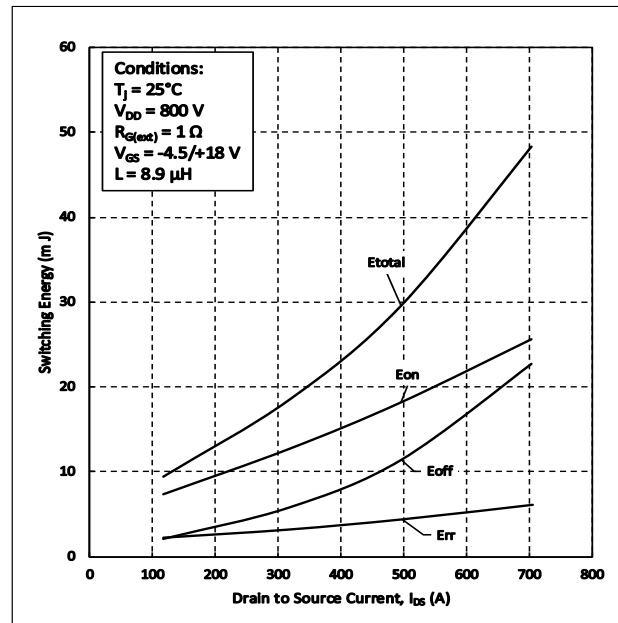


Figure 24. Clamped Inductive Switching Energy vs. Drain Current (800V)

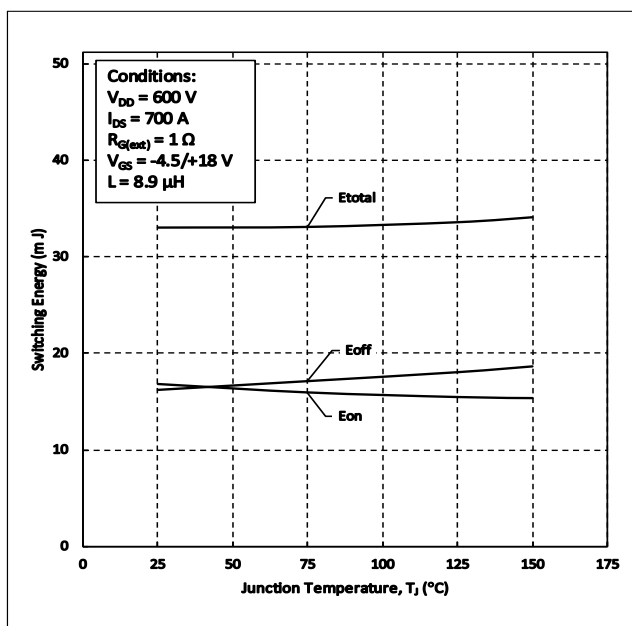


Figure 25. Clamped Inductive Switching Energy vs. Temperature

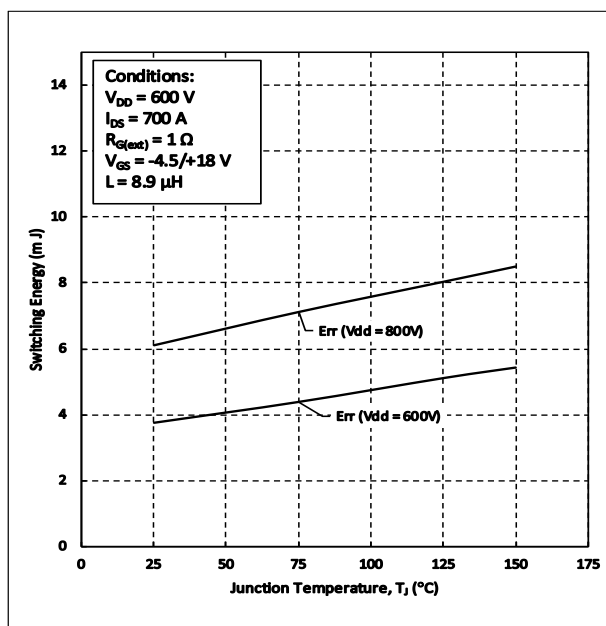


Figure 26. Reverse Recovery Energy vs. Temperature

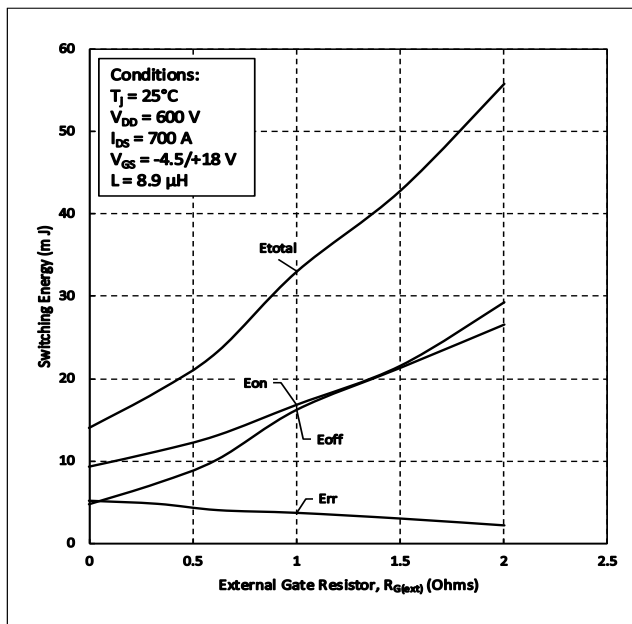


Figure 27. Clamped Inductive Switching Energy vs.  $R_{G(ext)}$

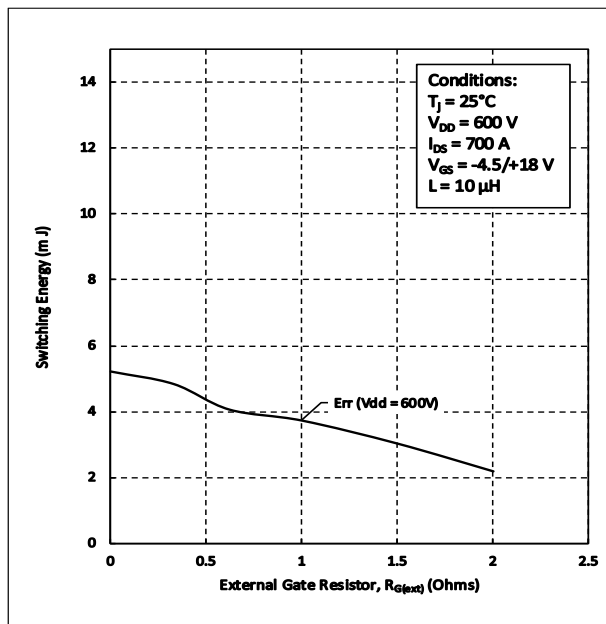


Figure 28. Reverse Recovery Energy vs.  $R_{G(ext)}$

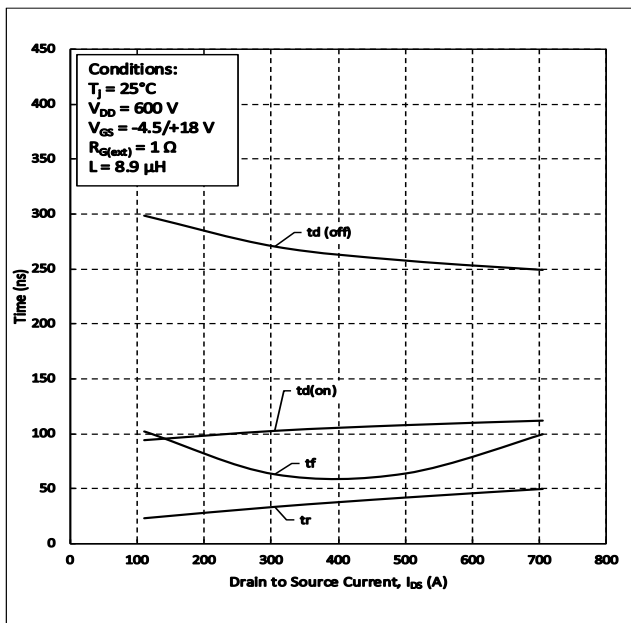


Figure 29. Switching Times vs. Drain Current

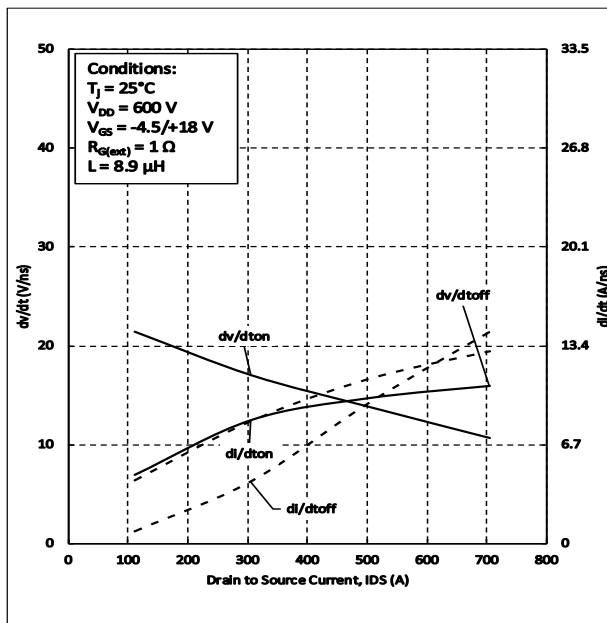


Figure 30.  $dv/dt$  and  $di/dt$  vs. Source Current

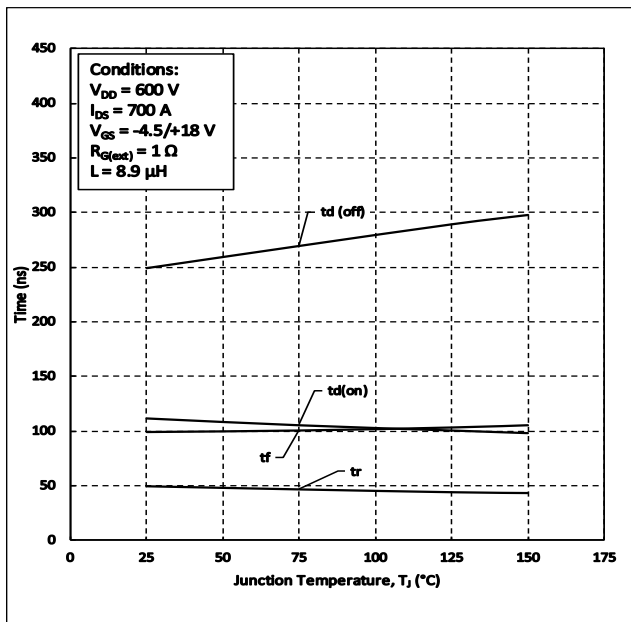


Figure 31. Switching Times vs. Temperature

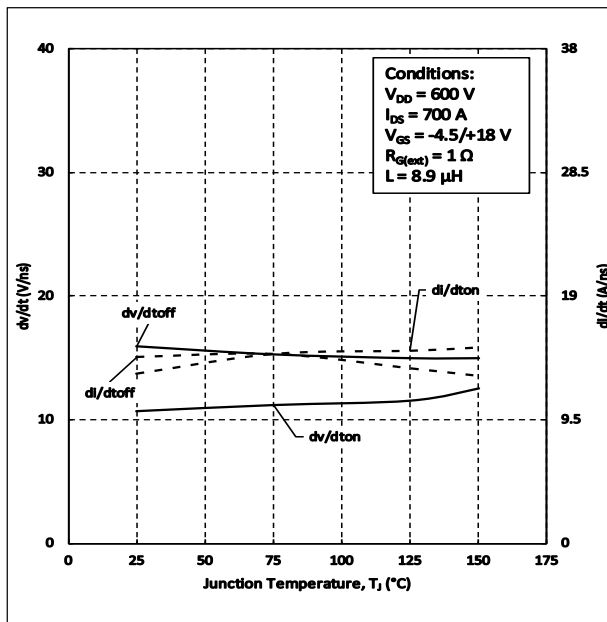


Figure 32.  $dv/dt$  and  $di/dt$  vs. Temperature

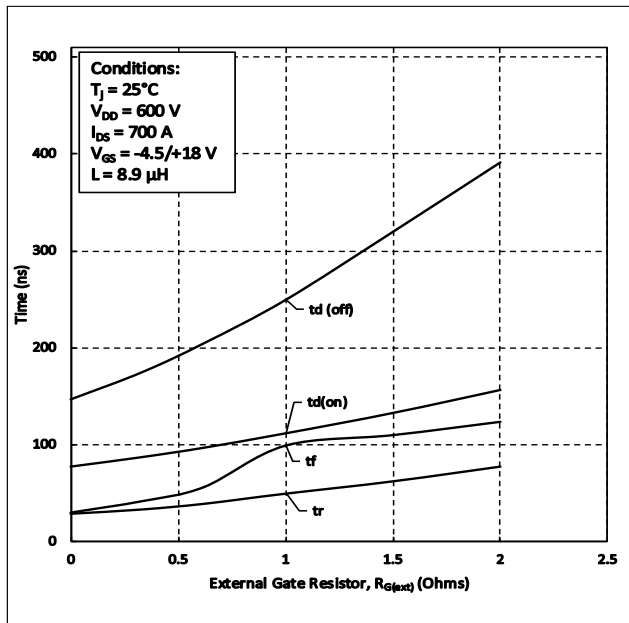


Figure 33. Switching Times vs.  $R_{G(ext)}$

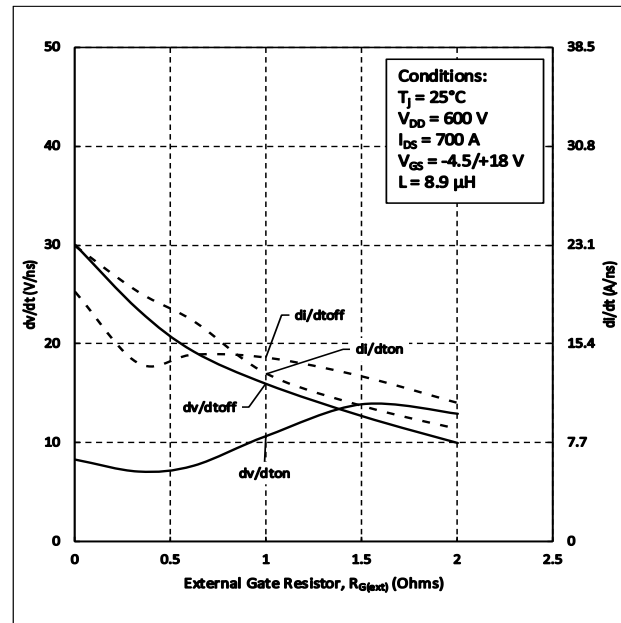


Figure 34.  $dv/dt$  and  $di/dt$  vs.  $R_{G(ext)}$

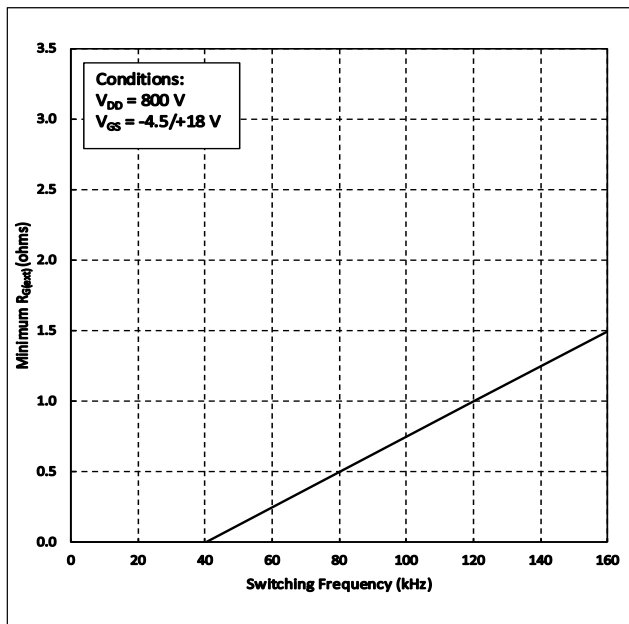


Figure 35. Frequency vs. Minimum  $R_{G(ext)}$

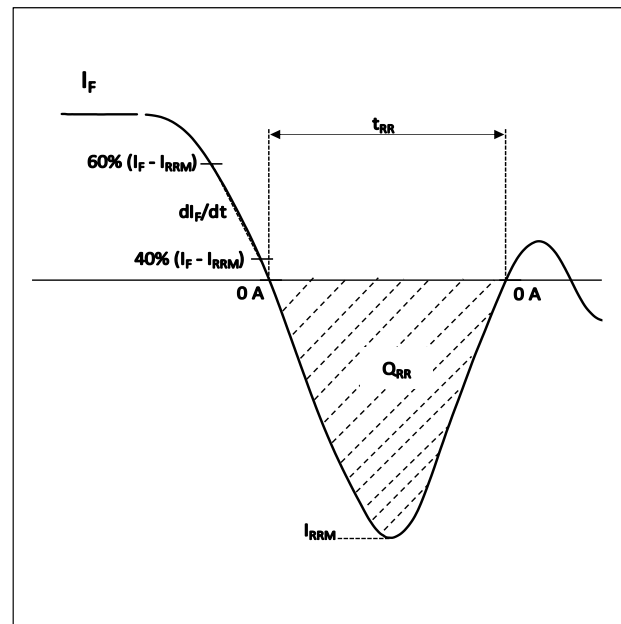


Figure 36. Reverse Recovery Definitions

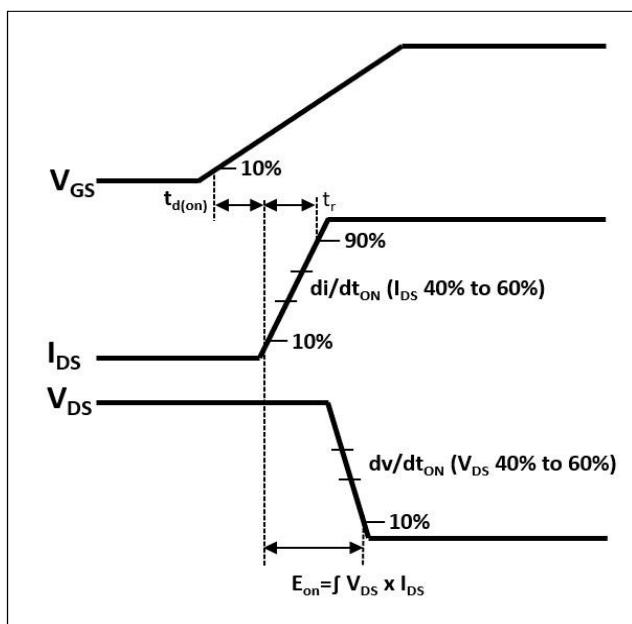


Figure 37. Turn-on Transient Definitions

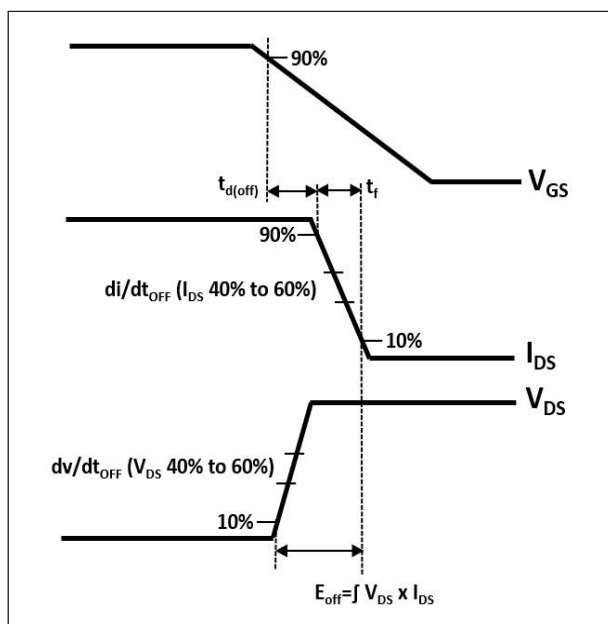
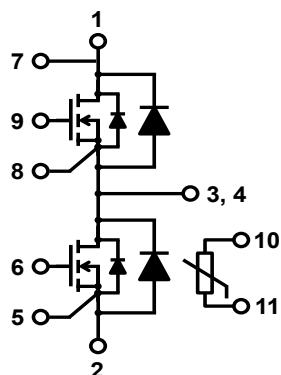


Figure 38. Turn-off Transient Definitions

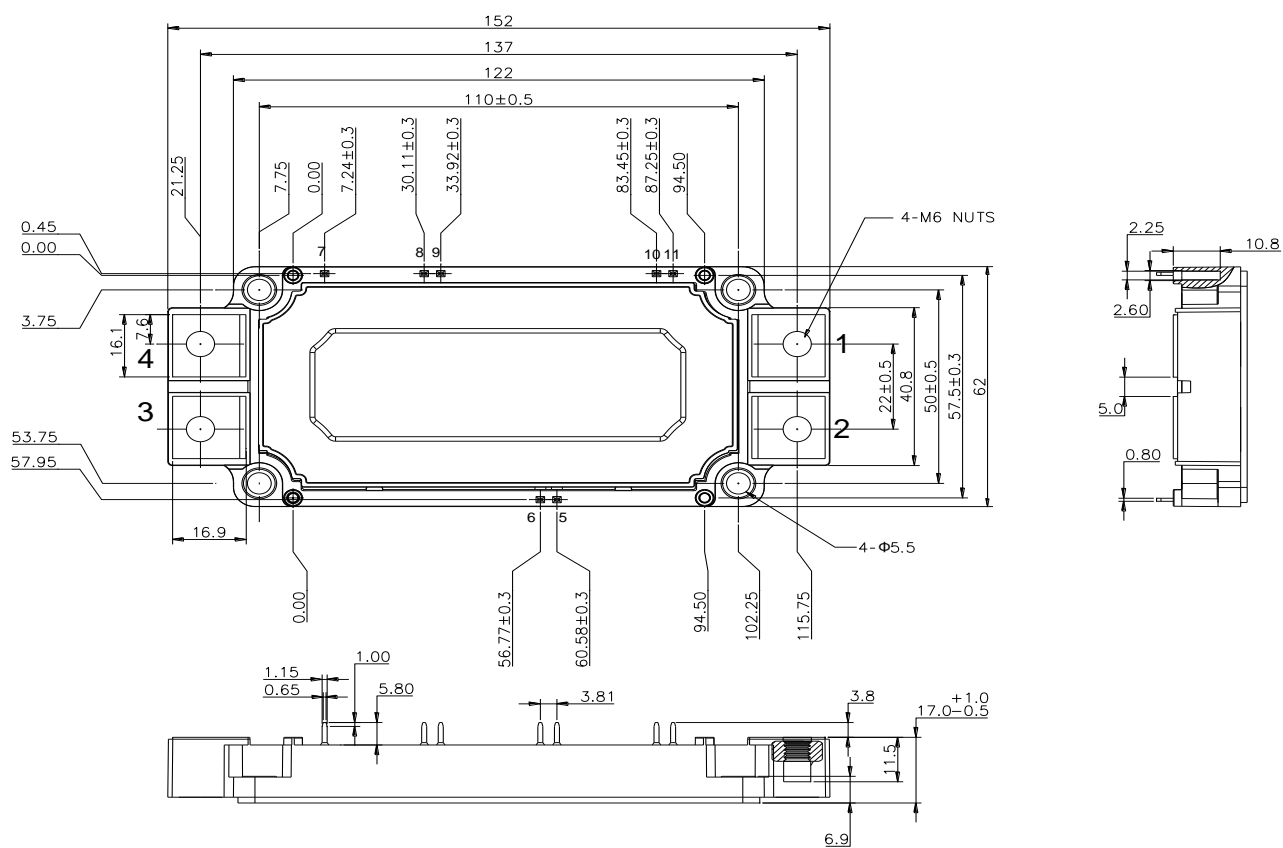
# QSiC™ 1200V SiC Half-Bridge Module

GCMS1P0B120S4B1

## Pinout and Circuit Diagram



## Package Dimensions (mm)



Revision History		
Date	Revision	Notes
1/16/2026	0.1	Preliminary release

**Notes****RoHS Compliance**

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2015/863 (RoHS3), as implemented July, 2019. RoHS Declarations for this product can be obtained from the Product Documentation sections of [www.SemiQ.com](http://www.SemiQ.com).

**REACH Compliance**

REACH substances of high concern (SVHC) information is available for this product. Since the European Chemicals Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact our office at SemiQ Headquarters in Lake Forest, California to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request. SemiQ Inc., reserves the right to make changes to the product specifications and data in this document without notice. SemiQ products are sold pursuant to SemiQ's terms and conditions of sale in place at the time of order acknowledgement.

This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, or air traffic control.

SemiQ makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SemiQ assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using SemiQ products.

To obtain additional technical information or to place an order for this product, please contact us. The information in this datasheet is provided by SemiQ.